


<b>Search Notes</b> 	<b>Application/Control No.</b> 10564288	<b>Applicant(s)/Patent Under Reexamination</b> TANAKA ET AL.
	<b>Examiner</b> KIM CHU	<b>Art Unit</b> 2627

SEARCHED			
Class	Subclass	Date	Examiner
369	47.1	5/26/2008	kc
369	47.28	5/26/2008	kc
369	47.3	5/26/2008	kc
369	47.48	5/26/2008	kc
369	53.22	5/26/2008	kc
369	59.19	5/26/2008	kc
369	112.01	5/26/2008	kc

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	5/26/2008	kc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner